

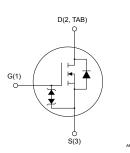


### Datasheet

# Automotive-grade N-channel 500 V, 61 mΩ typ., 38 A MDmesh<sup>™</sup> DM6 Power MOSFET in a D<sup>2</sup>PAK package



D<sup>2</sup>PAK



| Product status link |                    |  |  |  |  |
|---------------------|--------------------|--|--|--|--|
| STB47N50DM6AG       |                    |  |  |  |  |
| Product summary     |                    |  |  |  |  |
| Order code          | STB47N50DM6AG      |  |  |  |  |
| Marking             | 47N50DM6           |  |  |  |  |
| Package             | D <sup>2</sup> PAK |  |  |  |  |
| Packing             | Tape and reel      |  |  |  |  |

### **Features**

| Order code    | V <sub>DS</sub> | R <sub>DS(on)</sub> max. | ۱ <sub>D</sub> |
|---------------|-----------------|--------------------------|----------------|
| STB47N50DM6AG | 500 V           | 71 mΩ                    | 38 A           |

- AEC-Q101 gualified
- Fast-recovery body diode
- Lower R<sub>DS(on)</sub> per area vs previous generation
- Low gate charge, input capacitance and resistance
- 100% avalanche tested
- Extremely high dv/dt ruggedness
- Zener-protected

## **Applications**

Switching applications

## **Description**

This high-voltage N-channel Power MOSFET is part of the MDmesh<sup>TM</sup> DM6 fast-recovery diode series. Compared with the previous MDmesh fast generation, DM6 combines very low recovery charge ( $Q_{rr}$ ), recovery time ( $t_{rr}$ ) and excellent improvement in  $R_{DS(on)}$  per area with one of the most effective switching behaviors available in the market for the most demanding high-efficiency bridge topologies and ZVS phase-shift converters.

#### **Electrical ratings** 1

| Table 1. Absolute maximum ratings |  |  |  |  |
|-----------------------------------|--|--|--|--|
| Parameter                         |  |  |  |  |

| Symbol                        | Parameter   | Value      | Unit  |
|-------------------------------|---|------------|-------|
| V <sub>DS</sub>               | Drain-source voltage                                  | 500        | V     |
| V <sub>GS</sub>               | Gate-source voltage                                   | ±25        | V     |
| Ι <sub>D</sub>                | Drain current (continuous) at T <sub>C</sub> = 25 °C  | 38         | А     |
| Ι <sub>D</sub>                | Drain current (continuous) at T <sub>C</sub> = 100 °C | 24         | Α     |
| I <sub>D</sub> <sup>(1)</sup> | Drain current (pulsed)                                | 137        | Α     |
| P <sub>TOT</sub>              | Total dissipation at $T_C$ = 25 °C                    | 250        | W     |
| dv/dt <sup>(2)</sup>          | Peak diode recovery voltage slope                     | 50         | V/ns  |
| dv/dt <sup>(3)</sup>          | MOSFET dv/dt ruggedness                               | 100        | V/115 |
| TJ                            | Operating junction temperature range                  | -55 to 150 | °C    |
| T <sub>stg</sub>              | Storage temperature range                             | -55 10 150 | C     |

1. Pulse width limited by safe operating area

2.  $I_{SD} \leq 38$  A, di/dt  $\leq 800$  A/µs,  $V_{DS peak} < V_{(BR)DSS}$ ,  $V_{DD} = 400$  V

3.  $V_{DS} \leq 400 V$ 

### Table 2. Thermal data

| Symbol                              | Parameter                        | Value | Unit |
|-------------------------------------|----------------------------------|-------|------|
| R <sub>thj-case</sub>               | Thermal resistance junction-case | 0.5   | °C/W |
| R <sub>thj-pcb</sub> <sup>(1)</sup> | Thermal resistance junction-pcb  | 30    | 0/11 |

1. When mounted on 1 inch<sup>2</sup> FR-4, 2 Oz copper board.

### Table 3. Avalanche characteristics

| Symbol          | Parameter   | Value | Unit |
|-----------------|---|-------|------|
| I <sub>AR</sub> | Avalanche current, repetitive or not repetitive (pulse width limited by ${\rm T}_{\rm jmax})$ | 7     | А    |
| E <sub>AS</sub> | Single-pulse avalanche energy (starting $T_j$ = 25°C, $I_D$ = $I_{AR}$ , $V_{DD}$ = 100 V)    | 850   | mJ   |

# 2 Electrical characteristics

### $T_C$ = 25 °C unless otherwise specified

| Symbol               | Parameter                         | Test conditions   | Min. | Тур. | Max. | Unit |
|----------------------|-----------------------------------|---|------|------|------|------|
| V <sub>(BR)DSS</sub> | Drain-source breakdown voltage    | $V_{GS}$ = 0 V, I <sub>D</sub> = 1 mA                                       | 500  |      |      | V    |
|                      |                                   | $V_{GS}$ = 0 V, $V_{DS}$ = 500 V  |      |      | 5    | μA   |
| I <sub>DSS</sub>     | Zero gate voltage drain current   | $V_{GS}$ = 0 V, $V_{DS}$ = 500 V,<br>T <sub>C</sub> = 125 °C <sup>(1)</sup> |      |      | 100  | μA   |
| I <sub>GSS</sub>     | Gate body leakage current         | $V_{DS}$ = 0 V, $V_{GS}$ = ±25 V  |      |      | ±5   | μA   |
| V <sub>GS(th)</sub>  | Gate threshold voltage            | $V_{DS}$ = $V_{GS}$ , $I_D$ = 250 $\mu$ A                                   | 3    | 4    | 5    | V    |
| R <sub>DS(on)</sub>  | Static drain-source on-resistance | V <sub>GS</sub> = 10 V, I <sub>D</sub> = 19 A                               |      | 61   | 71   | mΩ   |

### Table 4. On/off-state

1. Defined by design, not subject to production test.

### Table 5. Dynamic

| Symbol           | Parameter                    | Test conditions  | Min. | Тур. | Max. | Unit |
|------------------|------------------------------|--|------|------|------|------|
| C <sub>iss</sub> | Input capacitance            |  | -    | 2300 | -    | pF   |
| C <sub>oss</sub> | Output capacitance           | $V_{DS}$ = 100 V, f = 1 MHz, $V_{GS}$ = 0 V            | -    | 140  | -    | pF   |
| C <sub>rss</sub> | Reverse transfer capacitance | -  | -    | 3.5  | -    | pF   |
| R <sub>G</sub>   | Intrinsic gate resistance    | f = 1 MHz open drain                                   | -    | 1.6  | -    | Ω    |
| Qg               | Total gate charge            | V <sub>DD</sub> = 400 V, I <sub>D</sub> = 38 A,        | -    | 57   | -    | nC   |
| Q <sub>gs</sub>  | Gate-source charge           | V <sub>GS</sub> = 0 to 10 V                            | -    | 12   | -    | nC   |
| Q <sub>gd</sub>  | Gate-drain charge            | (see Figure 14. Test circuit for gate charge behavior) | -    | 32   | -    | nC   |

### Table 6. Switching times

| Symbol              | Parameter           | Test conditions   | Min. | Тур. | Max. | Unit |
|---------------------|---------------------|---|------|------|------|------|
| t <sub>d(on)</sub>  | Turn-on delay time  | V <sub>DD</sub> = 200 V, I <sub>D</sub> = 19 A,                 | -    | 22   | -    | ns   |
| t <sub>r</sub>      | Rise time           | $R_G$ = 4.7 $\Omega$ , $V_{GS}$ = 10 V                          | -    | 5.4  | -    | ns   |
| t <sub>d(off)</sub> | Turn-off delay time | (see Figure 13. Test circuit for resistive load switching times | -    | 56   | -    | ns   |
| t <sub>f</sub>      | Fall time           | and Figure 18. Switching time waveform)                         | -    | 8.5  | -    | ns   |

### Table 7. Source-drain diode

| Symbol                          | Parameter                     | Test conditions | Min. | Тур. | Max. | Unit |
|---------------------------------|-------------------------------|-----------------|------|------|------|------|
| I <sub>SD</sub>                 | Source-drain current          |                 | -    |      | 38   | А    |
| I <sub>SDM</sub> <sup>(1)</sup> | Source-drain current (pulsed) |                 | -    |      | 137  | А    |

| Symbol                         | Parameter                | Test conditions   | Min. | Тур. | Max. | Unit |
|--------------------------------|--------------------------|---|------|------|------|------|
| V <sub>SD</sub> <sup>(2)</sup> | Forward on voltage       | I <sub>SD</sub> = 38 A, V <sub>GS</sub> = 0 V                                       | -    |      | 1.6  | V    |
| t <sub>rr</sub>                | Reverse recovery time    | I <sub>SD</sub> = 38 A, di/dt = 100 A/µs,   | -    | 113  |      | ns   |
| Qrr                            | Reverse recovery charge  | V <sub>DD</sub> = 60 V  | -    | 0.53 |      | μC   |
| I <sub>RRM</sub>               | Reverse recovery current | (see Figure 15. Test circuit for inductive load switching and diode recovery times) | -    | 9    |      | A    |
| t <sub>rr</sub>                | Reverse recovery time    | I <sub>SD</sub> = 38 A, di/dt = 100 A/μs,   | -    | 205  |      | ns   |
| Q <sub>rr</sub>                | Reverse recovery charge  | V <sub>DD</sub> = 60 V, T <sub>j</sub> = 150 °C                                     | -    | 2    |      | μC   |
| I <sub>RRM</sub>               | Reverse recovery current | (see Figure 15. Test circuit for inductive load switching and diode recovery times) | -    | 19.5 |      | A    |

1. Pulse width limited by safe operating area

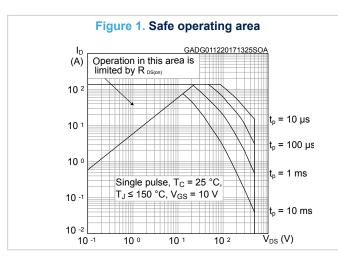
2. Pulsed: pulse duration =  $300 \ \mu$ s, duty cycle 1.5%

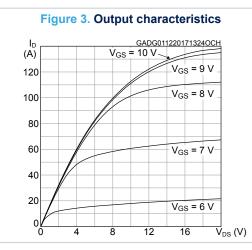
#### Table 8. Gate-source Zener diode

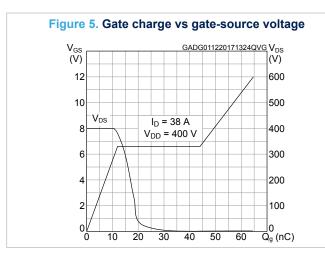
| Symbol               | Parameter                     | Test conditions               | Min. | Тур. | Max. | Unit |
|----------------------|-------------------------------|-------------------------------|------|------|------|------|
| V <sub>(BR)GSO</sub> | Gate-source breakdown voltage | $I_{GS}$ = ±1 mA, $I_D$ = 0 A | ±30  | -    | -    | V    |

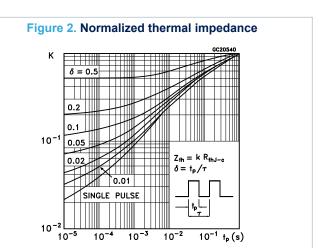
The built-in back-to-back Zener diodes are specifically designed to enhance the ESD performance of the device. The Zener voltage facilitates efficient and cost-effective device integrity protection, thus eliminating the need for additional external componentry.

## 2.1 Electrical characteristics (curves)









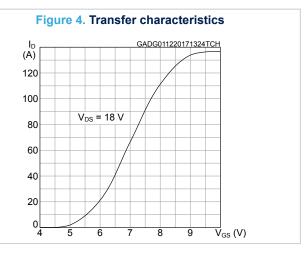
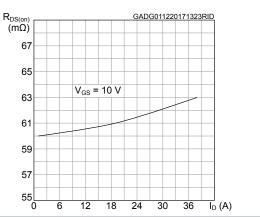
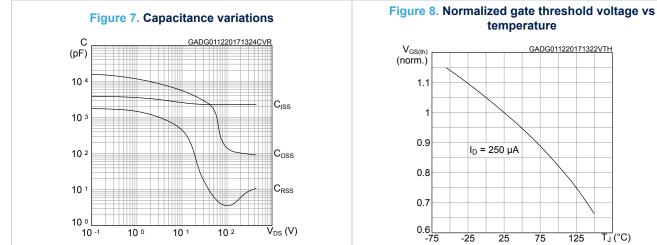
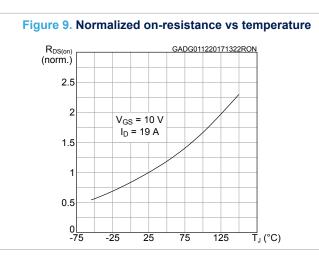


Figure 6. Static drain-source on-resistance



T<sub>J</sub>(°C)





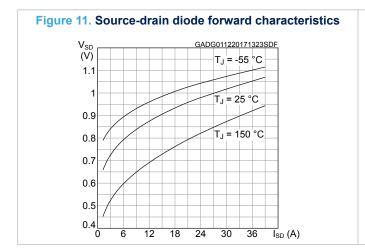


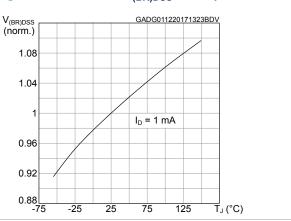
Figure 10. Normalized V<sub>(BR)DSS</sub> vs temperature

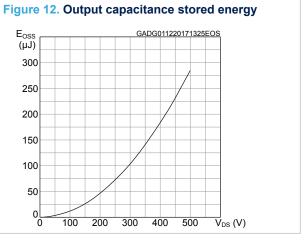
75

125

temperature

GADG011220171322VTH





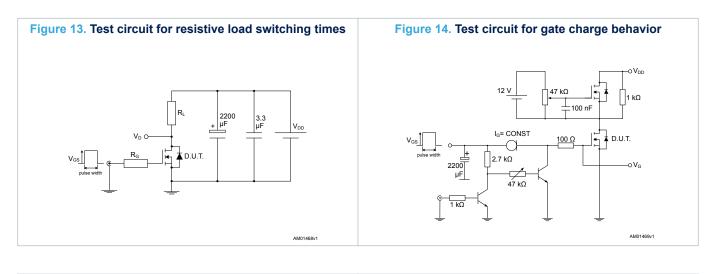
25

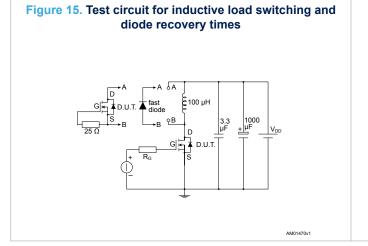
-25

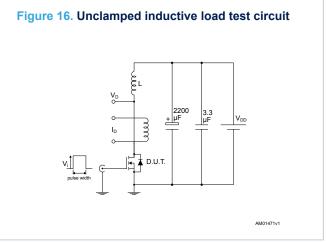
I<sub>D</sub> = 250 μA

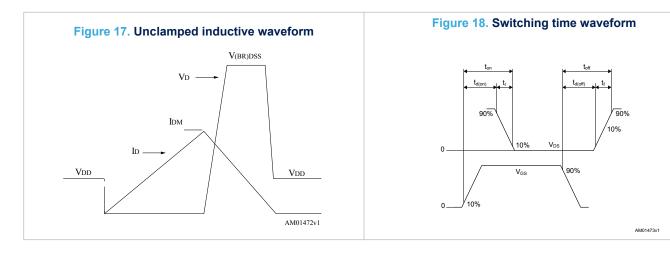


# 3 Test circuits









| DS12118 - Rev 4 |            |  |
|-----------------|------------|--|
| Downloaded from | Arrow.com. |  |

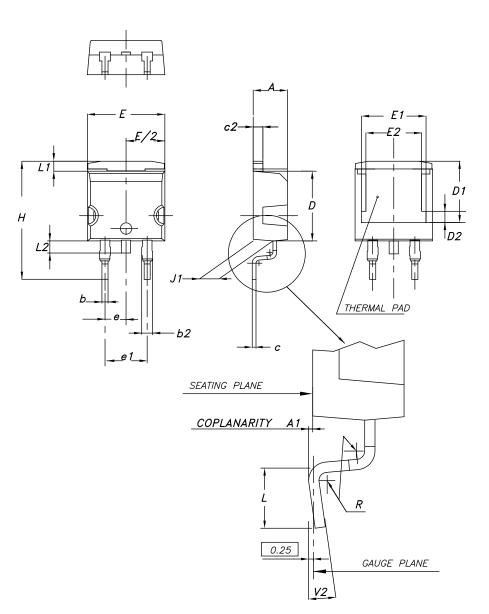
# 4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK<sup>®</sup> packages, depending on their level of environmental compliance. ECOPACK<sup>®</sup> specifications, grade definitions and product status are available at: www.st.com. ECOPACK<sup>®</sup> is an ST trademark.

## 4.1 D<sup>2</sup>PAK (TO-263) type A2 package information

57

### Figure 19. D<sup>2</sup>PAK (TO-263) type A2 package outline

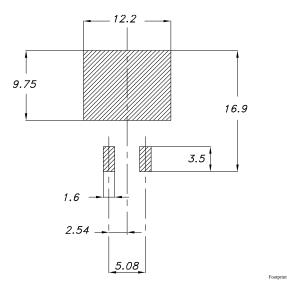


0079457\_A2\_25

| Dim. | mm    |      |       |  |
|------|-------|------|-------|--|
|      | Min.  | Тур. | Max.  |  |
| A    | 4.40  |      | 4.60  |  |
| A1   | 0.03  |      | 0.23  |  |
| b    | 0.70  |      | 0.93  |  |
| b2   | 1.14  |      | 1.70  |  |
| С    | 0.45  |      | 0.60  |  |
| c2   | 1.23  |      | 1.36  |  |
| D    | 8.95  |      | 9.35  |  |
| D1   | 7.50  | 7.75 | 8.00  |  |
| D2   | 1.10  | 1.30 | 1.50  |  |
| E    | 10.00 |      | 10.40 |  |
| E1   | 8.70  | 8.90 | 9.10  |  |
| E2   | 7.30  | 7.50 | 7.70  |  |
| е    |       | 2.54 |       |  |
| e1   | 4.88  |      | 5.28  |  |
| Н    | 15.00 |      | 15.85 |  |
| J1   | 2.49  |      | 2.69  |  |
| L    | 2.29  |      | 2.79  |  |
| L1   | 1.27  |      | 1.40  |  |
| L2   | 1.30  |      | 1.75  |  |
| R    |       | 0.40 |       |  |
| V2   | 0°    |      | 8°    |  |

### Table 9. D<sup>2</sup>PAK (TO-263) type A2 package mechanical data

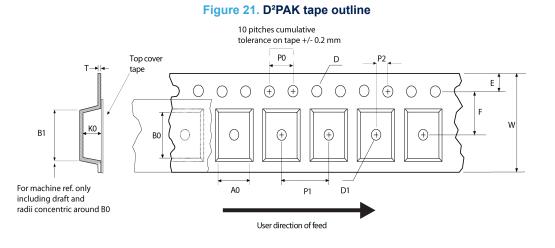
### Figure 20. D<sup>2</sup>PAK (TO-263) recommended footprint (dimensions are in mm)

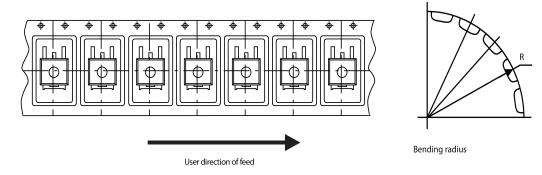


| DS12118 - Rev 4 |            |  |
|-----------------|------------|--|
| Downloaded from | Arrow.com. |  |

## 4.2 D<sup>2</sup>PAK packing information

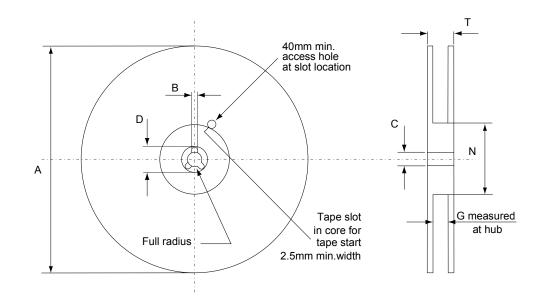
57





AM08852v1

### Figure 22. D<sup>2</sup>PAK reel outline



AM06038v1

### Table 10. D<sup>2</sup>PAK tape and reel mechanical data

| Таре |      | Reel |                  |      |      |  |
|------|------|------|------------------|------|------|--|
| Dim. | mm   |      | Dim.             | m    | mm   |  |
| Dim. | Min. | Max. |                  | Min. | Max. |  |
| A0   | 10.5 | 10.7 | A                |      | 330  |  |
| B0   | 15.7 | 15.9 | В                | 1.5  |      |  |
| D    | 1.5  | 1.6  | С                | 12.8 | 13.2 |  |
| D1   | 1.59 | 1.61 | D                | 20.2 |      |  |
| E    | 1.65 | 1.85 | G                | 24.4 | 26.4 |  |
| F    | 11.4 | 11.6 | Ν                | 100  |      |  |
| K0   | 4.8  | 5.0  | Т                |      | 30.4 |  |
| P0   | 3.9  | 4.1  |                  |      |      |  |
| P1   | 11.9 | 12.1 | Base quantity 10 |      | 1000 |  |
| P2   | 1.9  | 2.1  | Bulk quantity    |      | 1000 |  |
| R    | 50   |      |                  |      |      |  |
| Т    | 0.25 | 0.35 |                  |      |      |  |
| W    | 23.7 | 24.3 |                  |      |      |  |

57

# **Revision history**

| Date        | Revision | Changes  |
|-------------|----------|--|
| 21-Apr-2017 | 1        | Initial release.   |
| 24-May-2017 | 2        | Modified title.<br>Modified Table 2: "Absolute maximum ratings", Table 4: "Avalanche<br>characteristics", Table 5: "On/off-state", Table 6: "Dynamic", Table 7:<br>"Switching times", Table 8: "Source-drain diode" and Table 9: "Gatesource<br>Zener diode".<br>Minor text changes. |
| 06-Dec-2017 | 3        | Updated document title.<br>Updated <i>Table 4: "Avalanche characteristics"</i> and <i>Table 5: "On/off state"</i> .<br>Added <i>Section 2.1: "Electrical characteristics (curves)"</i> .<br>Updated <i>Section 4: "Package information"</i> .<br>Minor text changes                  |
| 21-05-2018  | 4        | Removed maturity status indication from cover page. The document status is production data.<br>Updated title and features list on cover page.<br>Minor text changes  |

### Table 11. Document revision history



#### IMPORTANT NOTICE - PLEASE READ CAREFULLY

STMicroelectronics NV and its subsidiaries ("ST") reserve the right to make changes, corrections, enhancements, modifications, and improvements to ST products and/or to this document at any time without notice. Purchasers should obtain the latest relevant information on ST products before placing orders. ST products are sold pursuant to ST's terms and conditions of sale in place at the time of order acknowledgement.

Purchasers are solely responsible for the choice, selection, and use of ST products and ST assumes no liability for application assistance or the design of Purchasers' products.

No license, express or implied, to any intellectual property right is granted by ST herein.

Resale of ST products with provisions different from the information set forth herein shall void any warranty granted by ST for such product.

ST and the ST logo are trademarks of ST. All other product or service names are the property of their respective owners.

Information in this document supersedes and replaces information previously supplied in any prior versions of this document.

© 2018 STMicroelectronics – All rights reserved